

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/665,023 | Applicant(s)/Patent Under Reexamination WATANABE, NAOMI | |
| | Examiner Thong Q Nguyen | Art Unit 2872 | Page 1 of 1 |

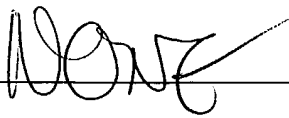
U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-4,548,481 | 10-1985 | Yamada, Kenji | 359/421 |
| | B | US-6,229,653 | 05-2001 | Kanai, Moriyasu | 359/643 |
| | C | US-6,059,721 | 05-2000 | Rudischhauser et al. | 600/167 |
| | D | US-5,576,892 | 11-1996 | Hotta et al. | 359/696 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------------|----------------|
| | N | JP 52-66446 | 06-1977 | Japan | Goto, Sanpei | 359/643 |
| | O | JP 2001-194593 | 07-2001 | Japan | Aikawa, Yasuyuki | 359/407 |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V |  |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.